

Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/777,053	SIMARD ET AL.
	Examiner F. Pierre VanderVegt	Art Unit 1644

ISSUE CLASSIFICATION			
ORIGINAL		CROSS REFERENCE(S)	
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)
435	320.1	536	23.4 23.5
INTERNATIONAL CLASSIFICATION		530	350 403
C 1 2 N	15/12	514	2 44
A 6 1 K	39/00	424	185.1 277.1
A 6 1 K	38/00		
A 0 1 N	43/00		
C 0 7 K	14/435		
F. Pierre VanderVegt 3/19/2007 (Assistant Examiner) (Date)		Christina Chan CHRISTINA CHAN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 1600 (Primary Examiner) (Date) 3/19/07	
Giga N. Duckett 3/21/07 (Legal Instruments Examiner) (Date)		Total Claims Allowed: 24	
		O.G. Print Claim(s) 1	O.G. Print Fig. none

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1	1	21	61	91	121	151	181
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4	4	34	64	94	124	154	184
5	5	22	65	95	125	155	185
6	6	23	66	96	126	156	186
7	7	24	67	97	127	157	187
8	8	18	68	98	128	158	188
9		21	69	99	129	159	189
10		40	70	100	130	160	190
11	11	41	71	101	131	161	191
12	12	42	72	102	132	162	192
13	13	43	73	103	133	163	193
14	14	44	74	104	134	164	194
15	15	45	75	105	135	165	195
16	16	46	76	106	136	166	196
17	17	47	77	107	137	167	197
18		48	78	108	138	168	198
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20		50	80	110	140	170	200
21	21	51	81	111	141	171	201
22		52	82	112	142	172	202
23	23	53	83	113	143	173	203
24		54	84	114	144	174	204
25	25	55	85	115	145	175	205
26	26	56	86	116	146	176	206
27		57	87	117	147	177	207
28		58	88	118	148	178	208
29		59	89	119	149	179	209
30		60	90	120	150	180	210